

Issue Classification

Don J. Ahern 7-20-06
(Assistant Examiner) (Date)

(Legal Instruments Examiner) 8-7-06 (Date)

EDDIE CHAN
SUPERVISORY PATENT EXAMINER
TECHNOLOGY CENTER 2100
(Primary Examiner) (Date)

Total Claims Allowed: 12

O.G.
Print Claim(s)

O.G.
Print Fig.

1

2

☒ Claims renumbered in the same order as presented by applicant☐ CPA

☐ T.D.

☐ R.1.47

Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original
1	1			31			61			91			121			181
2	2			32			62			92			122			182
3	3			33			63			93			123			183
4	4			34			64			94			124			184
5	5			35			65			95			125			185
6	6			36			66			96			126			186
7	7			37			67			97			127			187
8	8			38			68			98			128			188
9	9			39			69			99			129			189
10	10			40			70			100			130			190
11	11			41			71			101			131			191
	12			42			72			102			132			192
12	13			43			73			103			133			193
	14			44			74			104			134			194
	15			45			75			105			135			195
	16			46			76			106			136			196
	17			47			77			107			137			197
	18			48			78			108			138			198
	19			49			79			109			139			199
	20			50			80			110			140			200
	21			51			81			111			141			201
	22			52			82			112			142			202
	23			53			83			113			143			203
	24			54			84			114			144			204
	25			55			85			115			145			205
	26			56			86			116			146			206
	27			57			87			117			147			207
	28			58			88			118			148			208
	29			59			89			119			149			209
	30			60			90			120			150			210